

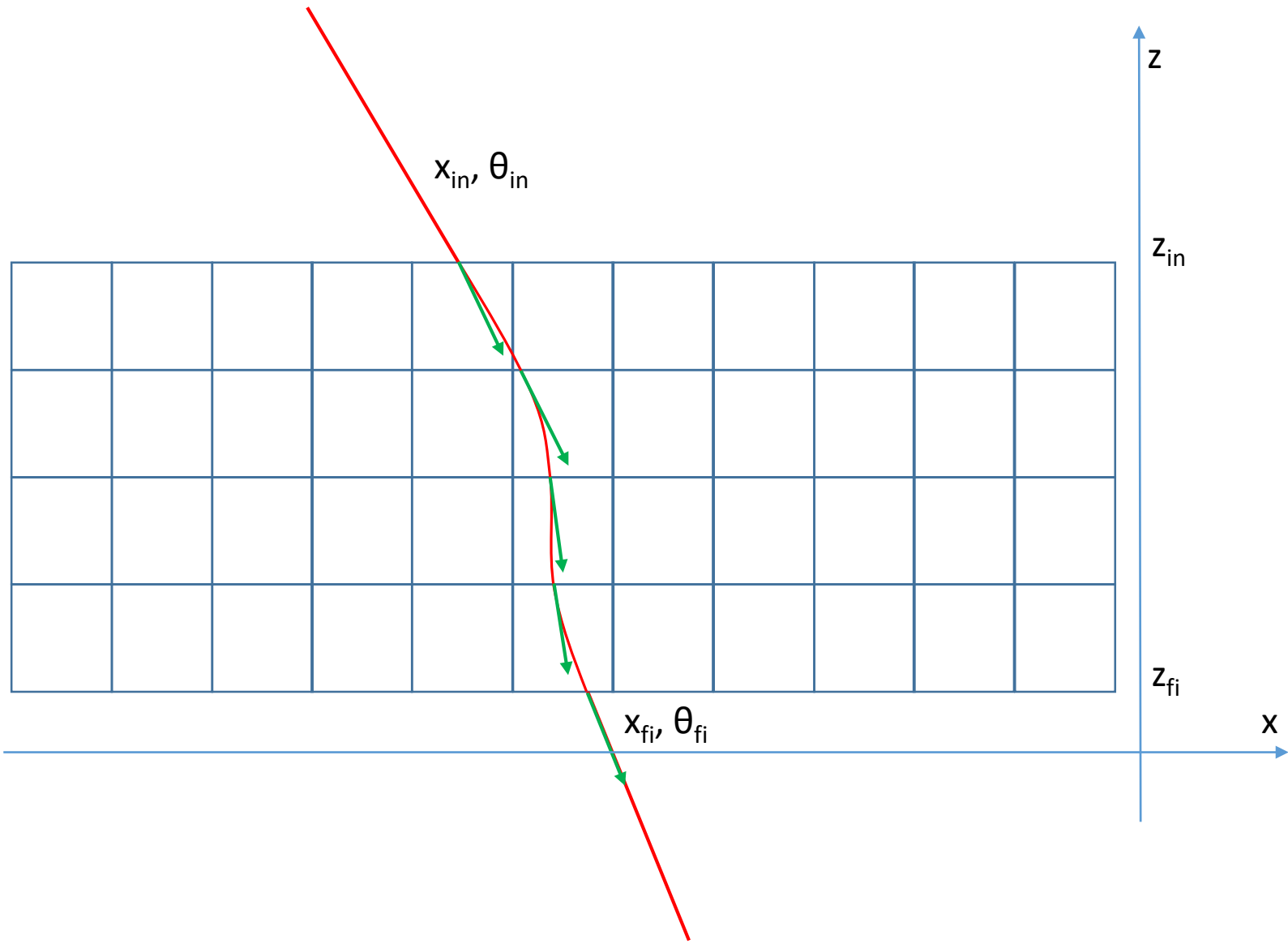
# Better $X_0$ estimation with likelihood approach

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# Statement of the problem of $X_0$ estimation

- Coordinate system:  $z$  vertical coordinate,  $xy$  describe surfaces
- Let us consider a voxelized volume impinged by muons from above ( $z=z_{\max}$ ), and their scattering and exit from below ( $z=z_{\min}$ ). Muons are detected at  $z_{\max}$  and  $z_{\min}$ , where  $x, y, \theta_x, \theta_y$  are measured with uncertainties  $\sigma_x, \sigma_y, \sigma_{\theta_x}, \sigma_{\theta_y}$ .
- We may model the scattering as individual variations  $\theta'_x = \theta_x + \Delta\theta_x$ ,  $\theta'_y = \theta_y + \Delta\theta_y$  due to interactions within each voxel (we omit transverse displacements here). These have a probability  $P(\Delta\theta | X_0)$  which here we consider a Gaussian with width scaling with the square root of  $X_0$  (we omit for now non-Gaussian tails and momentum dependence for simplicity in this simplified analytical treatment).
- It is then straightforward to write down the likelihood of the most probable trajectory (see next slide), as a function of the measurements, the angular variations  $\Delta\theta$ , and the  $X_0$  of the traversed voxels (see next slide):



# Likelihood for N layers

$$x_i = x_0 + h[\tan(\theta_0) + \tan(\theta_0 + \Delta\theta_0) + \tan(\theta_0 + \Delta\theta_0 + \Delta\theta_1) + \dots]$$

$$\theta_i = \theta_0 + \Delta\theta_0 + \Delta\theta_1 + \dots$$

$$L = \left\{ \prod_1^N \exp \left[ -\frac{(\Delta\theta_i)^2}{2\sigma(X_{0,i})^2} \right] \right\} \exp \left[ -\frac{[x_{fi} - x_{in} - h(\tan(\theta_0) + \tan(\theta_0 + \Delta\theta_0) + \tan(\theta_0 + \Delta\theta_0 + \Delta\theta_1) + \dots)]^2}{2[\sigma(x_{fi})^2 + \sigma(x_{in})^2]} \right] \exp \left[ -\frac{[\theta_{fi} - \theta_{in} - \Delta\theta_0 - \Delta\theta_1 - \dots]^2}{2[\sigma(\theta_{fi})^2 \sigma(\theta_{in})^2]} \right]$$

Above, the first line in the L expression is the probability of a given angular scattering given the  $X_0$  of the traversed voxel; the second line forces the muon starting at  $x_{in}$  to end up at  $x_{fi}$  after propagation, according to the first expression at the top. The third line similarly forces angles to match.

Note: Here we are considering only scattering in the xz plane. For the yz plane a corresponding set of terms exists. The only coupling of the two is in the  $X_0$ , which is the same for each traversed voxel in the two planes.

# Solution for a muon and for a batch

The likelihood above is analytical if:

- we omit the  $p$  dependence
- we parametrize, as we did in the expression, scatterings as Gaussian; however, a more complex analytical parametrization still allows the analyticity of  $L$

Note that we have taken also other approximations:

- all the scattering of a voxel is accounted for at the end of each voxel propagation (this is not an issue as long as we make voxels small)
- no displacement of trajectories in  $x$  and  $y$  occurs within a voxel

The solution for a single muon can be obtained for the displacements  $\Delta\theta$  if we assume we know the  $X_0$  of the layers traversed by the muon, and minimize  $-2\log L$ .

If we obtain those displacements, and calculate the likelihood at those values,  $L$  now becomes a function of the  $X_0$ s. It is still analytical. We can thus accumulate the values of  $L$  that correspond to that maximum for a batch of muons. At the end, we differentiate  $-2\log L$  as a function of each of the  $X_0$ , and obtain estimates for them.

The above method is approximated also because it only considers the most probable trajectory for each muon, given the  $X_0$  values it traverses. We can improve on this by randomly sampling variations of some of the  $\Delta\theta$  for each muon, obtaining additional possible trajectories and their likelihood. Those values of  $L$  will be smaller than the maximum, and we can accumulate them in the global batch-wise likelihood by weighting each contribution by their respective probability. I expect this second method to be more accurate.